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2 Application information (valid for each section A/B)

This IC has a built-in DC-DC step-up converter that, from a single source (8 V to 16 V), generates the voltages (V_{UP}) that let the integrated LDO post-regulator (generating the 13 V / 18 V LNB output voltages plus the 22 kHz DiSEqC tone) to work with a minimum dissipated power of 0.5 W typ. @ 500 mA load (the LDO drop voltage is internally kept at $V_{UP} - V_{OUT} = 1$ V typ.). The IC is also provided with an undervoltage lockout circuit that disables the whole circuit when the supplied V_{CC} drops below a fixed threshold (4.7 V typically). The step-up converter soft-start function reduces the inrush current during startup. The SS time is internally fixed at 4 ms typ. to switch from 0 to 13 V and 6 ms typ. to switch from 0 to 18 V.

2.1 DiSEqC data encoding (DSQIN pin)

The internal 22 kHz tone generator is factory trimmed in accordance with the DiSEqC standards, and can be activated in 3 different ways:

- 1) by an external 22 kHz source DiSEqC data connected to the DSQIN logic pin (TTL compatible). In this case the I²C tone control bits must be set: EXTM=TEN=1.
- 2) by an external DiSEqC data envelope source connected to the DSQIN logic pin. In this case the I²C tone control bits must be set: EXTM=0 and TEN=1.
- 3) through the TEN I²C bit if the 22 kHz presence is requested in continuous mode. In this case the DSQIN TTL pin must be pulled high and the EXTM bit set to "0".

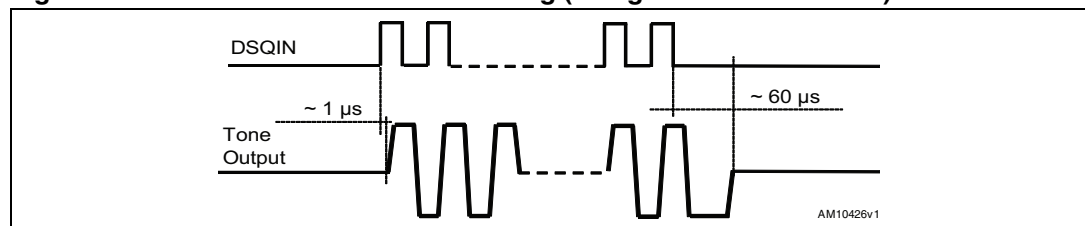
2.2 Data encoding by external 22 kHz tone TTL signal

In order to improve design flexibility, an external tone signal can be input to the DSQIN pin by setting the EXTM bit to "1".

The DSQIN is a logic input pin which activates the 22 kHz tone to the V_{OUT} pin, by using the LNBH26L integrated tone generator.

The output tone waveforms are internally controlled by the LNBH26L tone generator in terms of rise/fall time and tone amplitude, while, the external 22 kHz signal on the DSQIN pin is used to define the frequency and the duty cycle of the output tone. A TTL compatible 22 kHz signal is required for the proper control of the DSQIN pin function. Before sending the TTL signal on the DSQIN pin, the EXTM and TEN bits must be previously set to "1". As soon as the DSQIN internal circuit detects the 22 kHz TTL external signal code, the LNBH26L activates the 22 kHz tone on the V_{OUT} output with about 1 μ s delay from TTL signal activation, and it stops with about 60 μ s delay after the 22 kHz TTL signal on DSQIN has expired. Refer to [Figure 2](#).

Figure 2. Tone enable and disable timing (using external waveform)

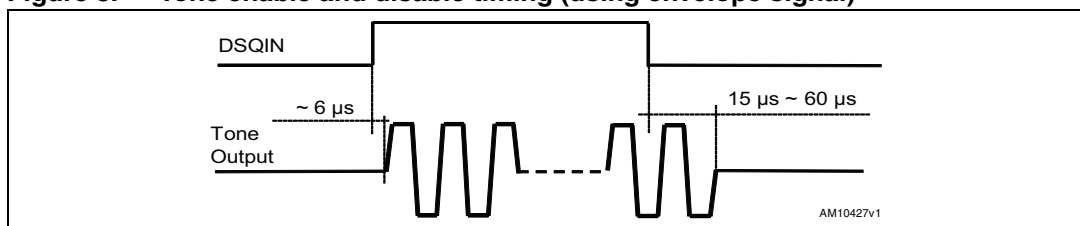


2.3 Data encoding by external DiSEqC envelope control through the DSQIN pin

If an external DiSEqC envelope source is available, it is possible to use the internal 22 kHz generator activated during the tone transmission by connecting the DiSEqC envelope source to the DSQIN pin. In this case the I²C tone control bits must be set: EXT_M=0 and TEN=1. In this way, the internal 22 kHz signal is superimposed to the V_{OUT} DC voltage to generate the LNB output 22 kHz tone. During the period in which the DSQIN is kept high the internal control circuit activates the 22 kHz tone output.

The 22 kHz tone on the V_{OUT} pin is activated with about 6 μs delay from the DSQIN TTL signal rising edge, and it stops with a delay time in the range from 15 μs to 60 μs after the 22 kHz TTL signal on DSQIN has expired (refer to [Figure 3](#)).

Figure 3. Tone enable and disable timing (using envelope signal)



2.4 Output current limit selection

The linear regulator current limit threshold can be set by an external resistor connected to the ISEL pin. The resistor value defines the output current limit by the equation:

Equation 1

$$I_{\text{MAX}}(\text{typ.}) = \frac{16578}{\text{RSEL}^{1.206}}$$

with ISET=0,

where RSEL is the resistor connected between ISEL and GND expressed in kΩ and I_{MAX}(typ.) is the typical current limit threshold expressed in mA. I_{MAX} can be set up to 750 mA for each channel. However, it is recommended to not exceed for a long period a total amount of current of 1 A from both sections (I_{OUT_A} + I_{OUT_B} < 1 A) in order to avoid the overtemperature protection from triggering and to thoroughly validate the PCB layout thermal management in real application environment conditions.

2.5 Output voltage selection

Each linear regulator channel output voltage level can be easily programmed in order to accomplish application specific requirements, using 4 + 4 bits of an internal DATA1 register (see [Section 7.3: Data registers](#) and [Table 13: Output voltage selection table \(Data1 register, write mode\)](#) for exact programmable values). Register writing is accessible via the I²C bus.

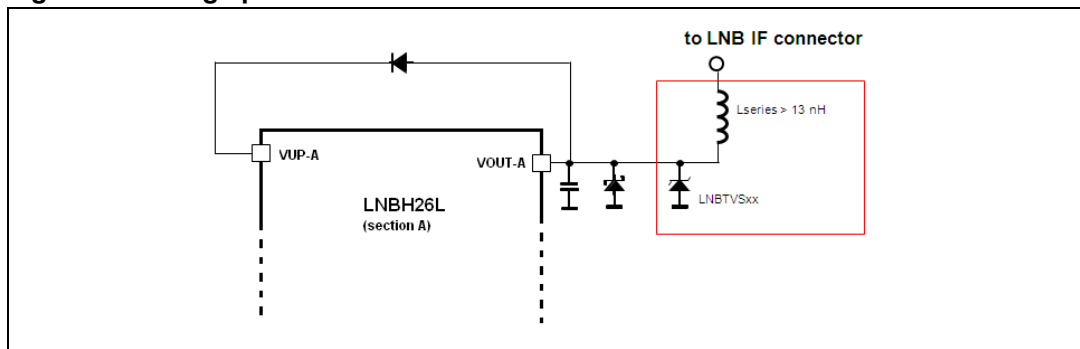
2.6 Diagnostic and protection functions

The LNBH26L has 4 diagnostic internal functions provided via the I²C bus, by reading 4 bits on the STATUS1 register (in read mode). All the diagnostic bits are, in normal operation (that is, no failure detected), set to LOW. One diagnostic bit is dedicated to the overtemperature (OTF), and two bits (one per section) are dedicated to overcurrent (OLF-A, OLF-B). One bit is dedicated to the input voltage power not good function (PNG). Once the OTF bit (or OLF-A, OLF-B or PNG) has been activated (set to "1"), it is latched to "1" until the relevant cause is removed and a new register reading operation is done.

2.7 Surge protection and TVS diodes

Each LNBH26L device section is directly connected to the antenna cable in a set-top box. Atmospheric phenomenon can cause high voltage discharges on the antenna cable causing damage to the attached devices. Surge pulses occur due to direct or indirect lightning strikes to an external (outdoor) circuit. This leads to currents or electromagnetic fields causing high voltage or current transients. Transient voltage suppressor (TVS) devices are usually placed, as shown in the following schematic, to protect each section of STB output circuits where the LNBH26L and other devices are electrically connected to the antenna cable.

Figure 4. Surge protection circuit



For this purpose the use of LNBTVSxx surge protection diodes specifically designed by ST is recommended. The selection of the LNBTVS diode should be made based on the maximum peak power dissipation that the diode is capable of supporting (see the LNBTVS datasheet for further details).

2.8 Power-on I²C interface reset and undervoltage lockout

The I²C interface built into the LNBH26L is automatically reset at power-on. As long as the V_{CC} stays below the undervoltage lockout (UVLO) threshold (4.7 V typ.), the interface does not respond to any I²C command and all DATA register bits are initialized to zeroes, therefore keeping the power blocks disabled. Once the V_{CC} rises above 4.8 V typ., the I²C interface becomes operative and the DATA registers can be configured by the main microprocessor.

2.9 PNG: input voltage minimum detection

When input voltage (VCC pin) is lower than LPD (low power diagnostic) minimum thresholds, the PNG I²C bit is set to “1”. Refer to the electrical characteristics table for threshold details.

2.10 OLF: overcurrent and short-circuit protection and diagnostic

In order to reduce the total power dissipation during an overload or a short-circuit condition, each section of the device is provided with a dynamic short-circuit protection. It is possible to set the short-circuit current protection either statically (simple current clamp) or dynamically through the corresponding PCL bit of the I²C DATA3 register. When the PCL (pulsed current limiting) bit is set to LOW, the overcurrent protection circuit works dynamically: as soon as an overload is detected, the output current is provided for T_{ON} time 90 ms and after that, the output is set in shutdown for a T_{OFF} time of typically 900 ms. Simultaneously, the corresponding diagnostic OLF I²C bit of the STATUS1 register is set to “1”. After this time has elapsed, the involved output is resumed for a time T_{ON}. At the end of T_{ON}, if the overload is still detected, the protection circuit cycles again through T_{OFF} and T_{ON}. At the end of a full T_{ON} in which no overload is detected, normal operation is resumed and the OLF diagnostic bit is reset to low after register reading is done. Typical T_{ON} + T_{OFF} time is 990 ms and is determined by an internal timer. This dynamic operation can greatly reduce the power dissipation in short-circuit condition, while still ensuring excellent power-on startup in most conditions. However, there may be some cases in which a highly capacitive load on the output can cause a difficult startup when the dynamic protection is chosen. This can be solved by initiating any power startup in static mode (PCL=1) and, then, switching to the dynamic mode (PCL=0) after a chosen amount of time depending on the output capacitance. Also in static mode, the diagnostic OLF bit goes to “1” (and the FLT pin is set to low) when the current clamp limit is reached and returns low when the overload condition is cleared and register reading is done.

After the overload condition is removed, normal operation can be resumed in two ways, according to the OLR I²C bit on the DATA4 register.

If OLR=1, all VSEL bits corresponding to the involved section are reset to “0” and the LNB section output (V_{OUT} pin) is disabled. To re-enable the output stage, the VSEL bits must be set again by the microprocessor and the OLF bit is reset to “0” after a register reading operation.

If OLR=0, the involved output is automatically re-enabled as soon as the overload condition is removed, and OLF bit is reset to “0” after a register reading operation.

2.11 OTF: thermal protection and diagnostic

The LNBH26L is also protected against overheating: when the junction temperature exceeds 150 °C (typ.), the step-up converter and both linear regulators are shut off, the diagnostic OTF bit in the STATUS1 register is set to “1”. After the overtemperature condition is removed, normal operation can be resumed in two ways, according to the THERM I²C bit on the DATA4 register.

If THERM=1, all VSEL bits are reset to “0” and both LNB outputs (V_{OUT} pins) are disabled. To re-enable the output stages, the VSEL bits must be set again by the microprocessor, while the OTF bit is reset to “0” after a register reading operation.

If THERM=0, outputs are automatically re-enabled as soon as the overtemperature condition is removed, while the OTF bit is reset to “0” after a register reading operation.

3 Pin configuration

Figure 5. Pin connections (top view)

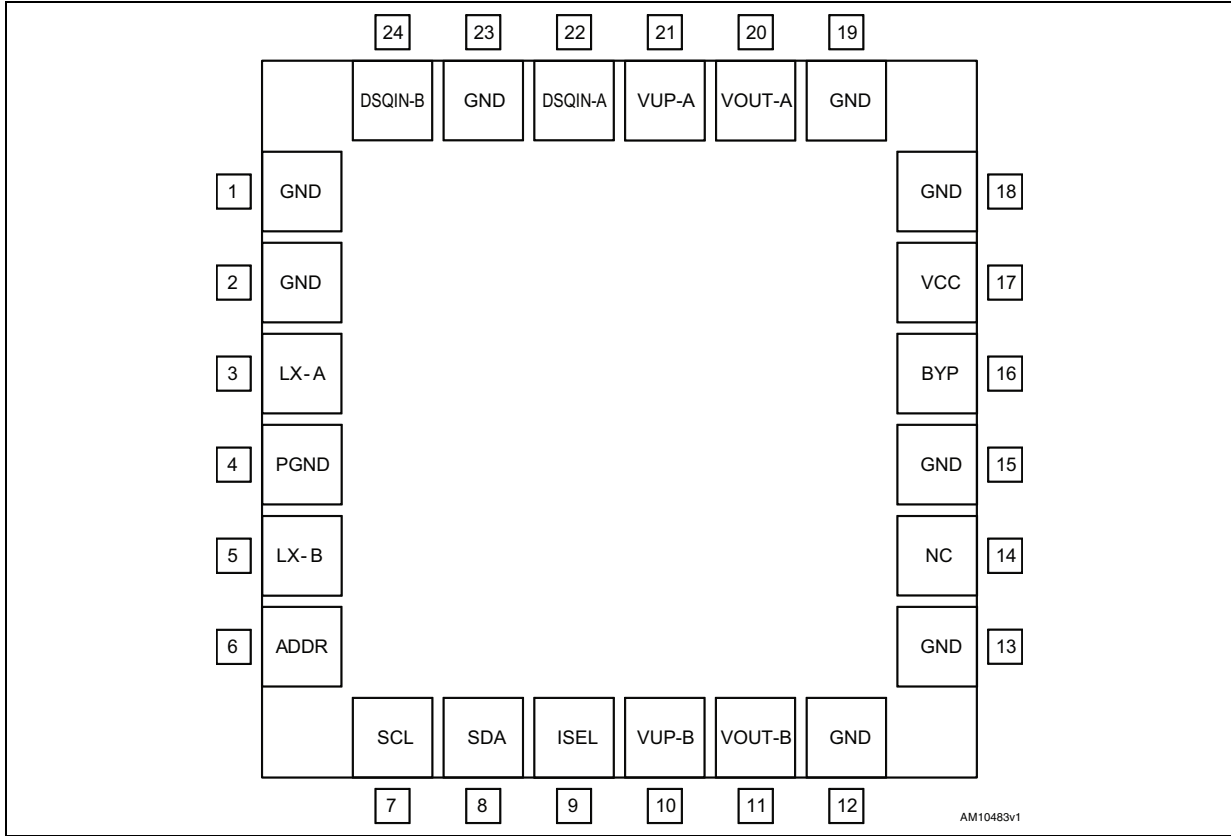


Table 2. Pin description

Pin n°	Symbol	Name	Pin function
3	LX-A	N-Mos drain	Channel A, integrated N-channel Power MOSFET drain.
4	P-GND	Power ground	DC-DC converter power ground. To be connected directly to the Epad.
5	LX-B	N-Mos drain	Channel B, integrated N-channel Power MOSFET drain.
6	ADDR	Address setting	Two I ² C bus addresses available by setting the Address pin level voltage. See the Address pin characteristics table.
7	SCL	Serial clock	Clock from I ² C bus.
8	SDA	Serial data	Bi-directional data from/to I ² C bus.
9	ISEL	Current selection for both channel A and B	The resistor “RSEL” connected between ISEL and GND defines the linear regulator current limit threshold. Refer to “output current limit selection” Section 2 . The RSEL resistor defines the same current limit both for channels A and B.
1, 2, 12, 13, 15, 18, 19, 23	GND	Analog ground	Analog circuits ground. To be connected directly to the Epad.

Table 2. Pin description (continued)

Pin n°	Symbol	Name	Pin function
10	V _{UP-B}	Channel B step-up voltage	Input of channel B linear post-regulator. The voltage on this pin is monitored by the internal channel B step-up controller to keep a minimum dropout across the linear pass transistor.
11	V _{OUT-B}	Channel B, LNB output port	Output of channel B integrated very low-drop linear regulator. Refer to Table 13 for voltage selection and description.
14	N.C.	Not internally connected	Not internally connected pin. Set floating if not used.
16	BYP	Bypass capacitor	Needed for internal pre-regulator filtering. The BYP pin is intended only to connect an external ceramic capacitor. Any connection of this pin to an external current or voltage sources may cause permanent damage to the device.
17	V _{CC}	Supply input	8 to 16 V IC DC-DC power supply.
20	V _{OUT-A}	Channel A, LNB output port	Output of channel A integrated very low-drop linear regulator. Refer to Table 13 for voltage selection and description.
21	V _{UP-A}	Channel A step-up voltage	Input of channel A linear post-regulator. The voltage on this pin is monitored by the internal channel A step-up controller to keep a minimum dropout across the linear pass transistor.
22	DSQIN-A	DSQIN for DiSEqC envelope input or external 22 KHz TTL input	It is intended for channel A 22 kHz tone control. It can be used as DiSEqC envelope input or external 22 kHz TTL input depending on the EXTM-A I ² C bit setting as follows: If EXTM-A=0, TEN-A=1: it accepts the DiSEqC envelope code from the main microcontroller. The LNBH26L uses this code to modulate the internally generated 22 kHz carrier. If EXTM-A=TEN-A=1: it accepts external 22 kHz logic signals which activate the 22 kHz tone output (refer to Section 2.2). Pull up high if the tone output is activated only by the TEN-A I ² C bit.
24	DSQIN-B	DSQIN for DiSEqC envelope Input or external 22 KHz TTL input	It is intended for channel B 22 kHz tone control. It can be used as DiSEqC envelope input or external 22 kHz TTL input depending on the EXTM-B I ² C bit setting as follows: If EXTM-B=0, TEN-B=1: it accepts the DiSEqC envelope code from the main microcontroller. The LNBH26L uses this code to modulate the internally generated 22 kHz carrier. If EXTM-A=TEN-A=1: it accepts external 22 kHz logic signals which activate the 22 kHz tone output (refer to Section 2.2). Pull up high if the tone output is activated only by TEN-B I ² C bit.
Epad	Epad	Exposed pad	To be connected with power grounds and to the ground layer through vias to dissipate the heat.

4 Maximum ratings

Table 3. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{CC}	DC power supply input voltage pins	-0.3 to 20	V
V_{UP}	DC input voltage	-0.3 to 40	V
I_{OUT}	Output current	Internally limited	mA
V_{OUT}	DC output pin voltage	-0.3 to 40	V
V_I	Logic input pin voltage (SDA, SCL, DSQIN, ADDR pins)	-0.3 to 7	V
LX	LX input voltage	-0.3 to 30	V
V_{BYP}	Internal reference pin voltage	-0.3 to 4.6	V
ISEL	Current selection pin voltage	-0.3 to 3.5	V
T_{STG}	Storage temperature range	-50 to 150	°C
T_J	Operating junction temperature range	-25 to 125	°C
ESD	ESD rating with human body model (HBM) all pins, unless power output pins	2	kV
	ESD rating with human body model (HBM) for power output pins	4	

Table 4. Thermal data

Symbol	Parameter	Value	Unit
R_{thJC}	Thermal resistance junction-case	2	°C/W
R_{thJA}	Thermal resistance junction-ambient with device soldered on 2s2p 4-layer PCB provided with thermal vias below the exposed pad.	40	°C/W

Note: Absolute maximum ratings are those values beyond which damage to the device may occur. These are stress ratings only and functional operation of the device at these conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. All voltage values are with respect to the network ground terminal.

5 Typical application circuits

Figure 6. DiSEqC 1.x application circuit

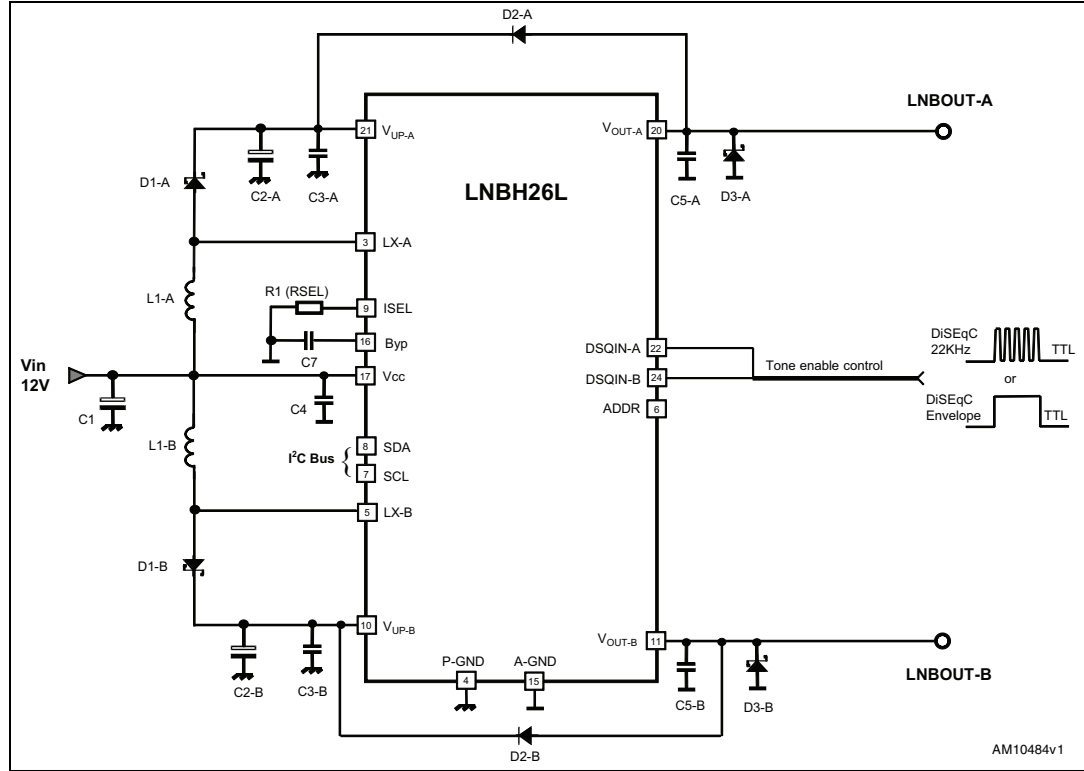


Table 5. DiSEqC 1.x bill of material (valid for A and B channels except for C1, C4, C7 and R1)

Component	Notes
R1 (RSEL)	SMD resistor. Refer to Table 12 and the ISEL pin description in Table 2 .
C1, C2	> 25 V electrolytic capacitor, 100 μ F is suitable.
C3	From 470 nF to 2.2 μ F ceramic capacitor. Higher values allow lower DC-DC noise.
C5	From 100 nF to 220 nF ceramic capacitor. Higher values allow lower DC-DC noise.
C4, C7	220 nF ceramic capacitors.
D1	STPS130A or similar Schottky diode.
D3	BAT54, BAT43, 1N5818, or any low power schottky diode with $I_F(AV) > 0.2$ A, $V_{RRM} > 25$ V, $V_F < 0.5$ V. To be placed as close as possible to the V_{OUT} pin.
D2	1N4001-07, S1A-S1M, or any similar general purpose rectifier.
L1	10 μ H inductor with $I_{sat} > I_{peak}$ where I_{peak} is the boost converter peak current.

6 I²C bus interface

Data transmission from the main microprocessor to the LNBH26L, and vice versa, takes place through the 2-wire I²C bus interface, consisting of the 2-line SDA and SCL (pull-up resistors to positive supply voltage must be externally connected).

6.1 Data validity

As shown in [Figure 7](#), the data on the SDA line must be stable during the high semi-period of the clock. The high and low state of the data line can only change when the clock signal on the SCL line is LOW.

6.2 START and STOP condition

As shown in [Figure 8](#), a START condition is a high to low transition of the SDA line while SCL is HIGH. The STOP condition is a low to high transition of the SDA line while SCL is HIGH. A STOP condition must be sent before each START condition.

6.3 Byte format

Every byte transferred to the SDA line must contain 8 bits. Each byte must be followed by an acknowledge bit. The MSb is transferred first.

6.4 Acknowledge

The master (microprocessor) puts a resistive high level on the SDA line during the acknowledge clock pulse (see [Figure 9](#)). The peripheral (LNBH26L) which acknowledges must pull down (LOW) the SDA line during the acknowledge clock pulse, so that the SDA line is stable low during this clock pulse. The peripheral which has been addressed must generate an acknowledge after the reception of each byte, otherwise the SDA line remains at the high level during the ninth clock pulse time. In this case the master transmitter can generate the STOP information in order to abort the transfer. The LNBH26L won't generate acknowledge if the V_{CC} supply is below the undervoltage lockout threshold (4.7 V typ.).

6.5 Transmission without acknowledge

If the detection of LNBH26L acknowledge is not necessary, the microprocessor can use a simpler transmission; it simply waits one clock without checking the slave acknowledging, and sends the new data. This approach is of course less protected from misworking and decreases noise immunity.

Figure 7. Data validity on the I²C bus

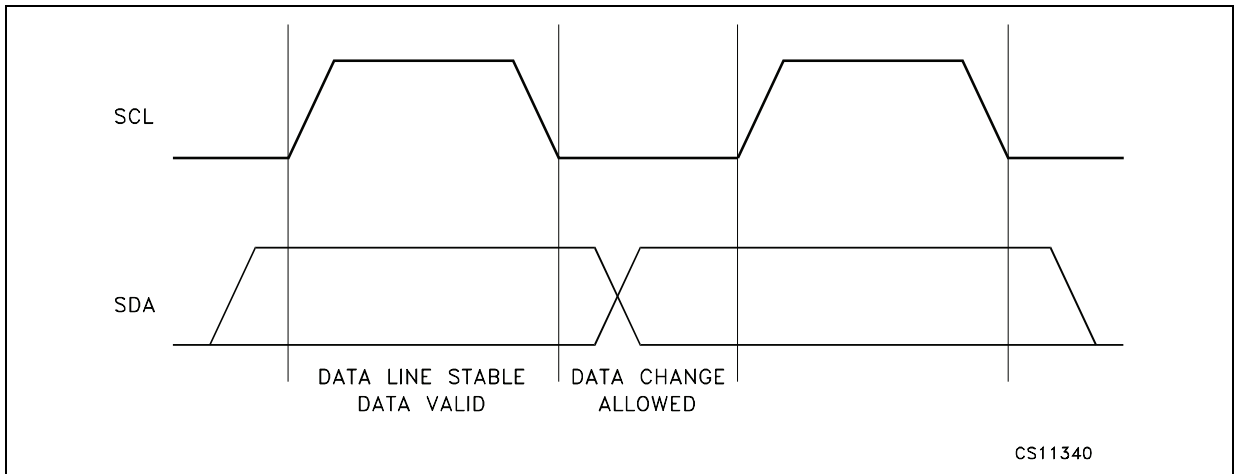


Figure 8. Timing diagram of I²C bus

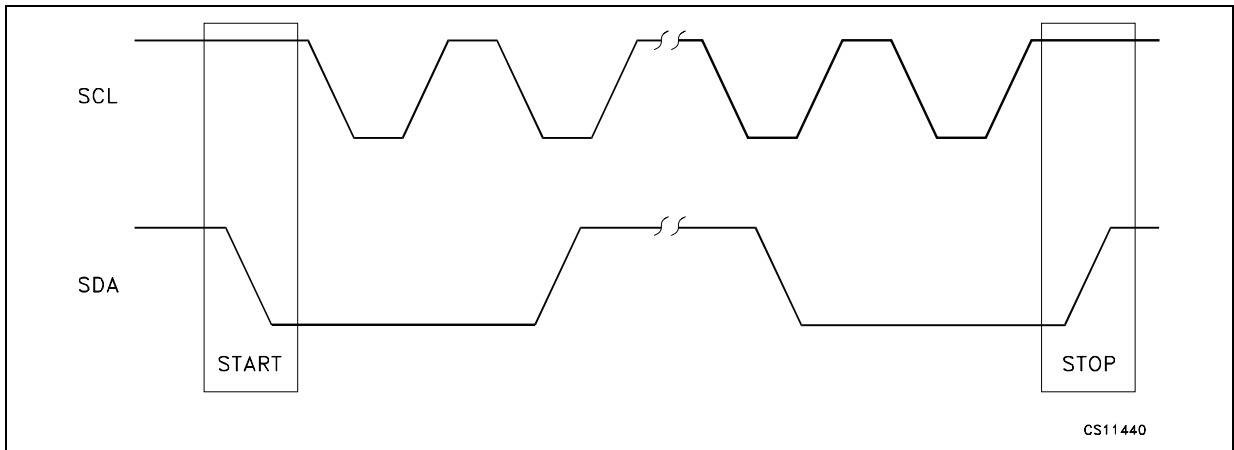
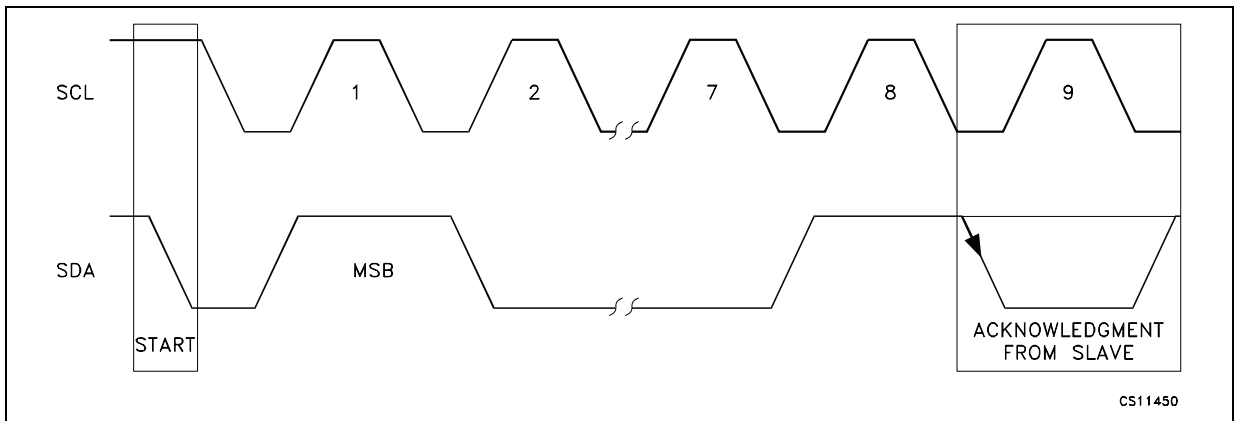


Figure 9. Acknowledge on the I²C bus

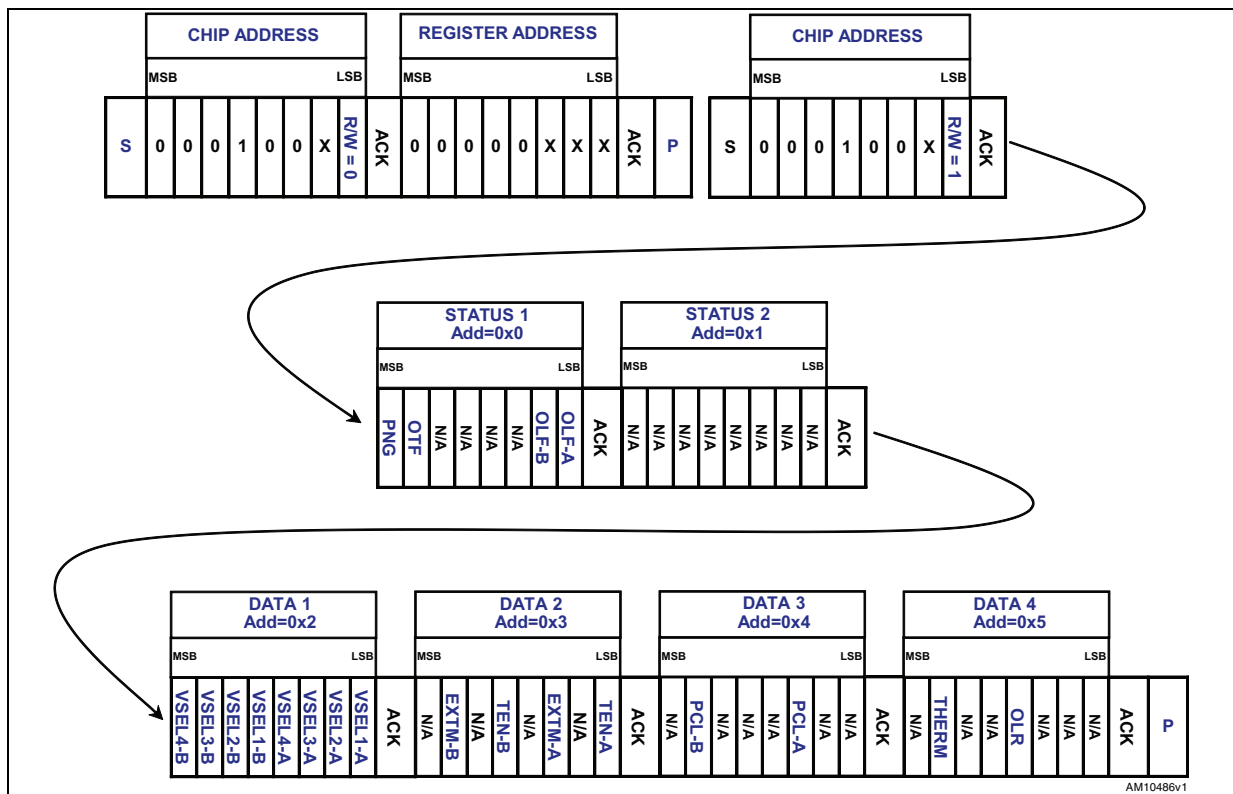


7.2 Read mode transmission

In read mode the bytes sequence must be as follows:

- a START condition (S)
- a chip address byte with the LSb bit R/W=0
- the register address byte of the internal first register to be accessed
- a STOP condition (P)
- a new master transmission with the chip address byte and the LSb bit R/W=1
- after the acknowledge, the LNBH26L starts to send the addressed register content. As long as the master keeps the acknowledge LOW, the LNBH26L transmits the next address register byte content.
- the transmission is terminated when the master sets the acknowledge high with a following stop bit.

Figure 11. Example of reading procedure starting with first status address 0X0 ^(b)



ACK = Acknowledge

S = Start

P = Stop

R/W = 1/0, read/write bit

X = 0/1, set the values to select the chip address (see [Table 15](#) for pin selection) and to select the register address (see [Table 6](#) to [Table 11](#)).

- b. The reading procedure can start from any register address (Status 1, 2 or Data1..4) by simply setting the X values in the register address byte (after the first chip address in the above figure). It can be also stopped from the master by sending a STOP condition after any acknowledge bit.

7.3 Data registers

The DATA 1..4 registers can be addressed both in write and read mode. In read mode they return the last writing byte status received in the previous write transmission.

The following tables provide the register address values of Data 1..4 and a function description of each bit.

Table 6. DATA 1 (read/write register. Register address = 0X2)

Bit	Name	CH	Value	Description
Bit 0 (LSb)	VSEL1-A	A	0/1	Channel A output voltage selection bits. (Refer to Table 13)
Bit 1	VSEL2-A		0/1	
Bit 2	VSEL3-A		0/1	
Bit 3	VSEL4-A		0/1	
Bit 4	VSEL1-B	B	0/1	Channel B output voltage selection bits. (Refer to Table 13)
Bit 5	VSEL2-B		0/1	
Bit 6	VSEL3-B		0/1	
Bit 7 (MSb)	VSEL4-B		0/1	

N/A = Reserved bit.

All bits reset to "0" at power-on.

Table 7. DATA 2 (read/write register. Register address = 0X3)

Bit	Name	CH	Value	Description	
Bit 0 (LSb)	TEN-A	A	1	22 kHz tone enabled. Tone output controlled by the DSQIN pin	
			0	22 kHz tone output disabled	
Bit 1	N/A		0	Reserved. Keep to "0".	
Bit 2	EXTM-A		1	DSQIN input pin is set to receive external 22 kHz TTL signal source	
			0	DSQIN input pin is set to receive external DiSEqC envelope TTL signal	
Bit 3	N/A		0	Reserved. Keep to "0".	
Bit 4	TEN-B		B	1	22 kHz tone enabled. Tone output controlled by the DSQIN pin
				0	22 kHz tone output disabled
Bit 5	N/A	0		Reserved. Keep to "0".	
Bit 6	EXTM-B	1		DSQIN input pin is set to receive external 22 kHz TTL signal source	
		0		DSQIN input pin is set to receive external DiSEqC envelope TTL signal	
Bit 7 (MSb)	N/A	0		Reserved. Keep to "0".	

N/A = Reserved bit.

All bits reset to "0" at power-on.

Table 8. DATA 3 (read/write register. Register address = 0X4)

Bit	Name	CH	Value	Description
Bit 0 (LSb)	N/A	A	0	Reserved. Keep to "0"
Bit 1	N/A		0	Reserved. Keep to "0"
Bit 2	PCL-A		1	Pulsed (Dynamic) LNB output current limiting is deactivated
			0	Pulsed (Dynamic) LNB output current limiting is activated
Bit 3	N/A		0	Reserved. Keep to "0"
Bit 4	N/A	B	0	Reserved. Keep to "0"
Bit 5	N/A		0	Reserved. Keep to "0"
Bit 6	PCL-B		1	Pulsed (Dynamic) LNB output current limiting is deactivated
			0	Pulsed (Dynamic) LNB output current limiting is activated
Bit 7 (MSb)	N/A		0	Reserved. Keep to "0"

N/A = Reserved bit.

All bits reset to "0" at power-on.

Table 9. DATA 4 (read/write register. Register address = 0X5)

Bit	Name	CH	Value	Description
Bit 0 (LSb)	N/A	-	0	Reserved. Keep to "0".
Bit 1	N/A	-	0	Reserved. Keep to "0".
Bit 2	N/A	-	0	Reserved. Keep to "0".
Bit 3	OLR	A/B	1	In the case of overload protection activation (OLF=1), all VSEL 1..4 bits are reset to "0" and LNB output (V _{OUT} pin) is disabled. The VSEL bits must be set again by the master after the overcurrent condition is removed (OLF=0).
			0	In the case of overload protection activation (OLF=1) the LNB output (V _{OUT} pin) is automatically enabled as soon as the overload condition is removed (OLF=0) with the previous VSEL bits setting.
Bit 4	N/A	-	0	Reserved. Keep to "0".
Bit 5	N/A	-	0	Reserved. Keep to "0".
Bit 6	THERM	A/B	1	If thermal protection is activated (OTF=1), all VSEL 1..4 bits are reset to "0" and LNB output (V _{OUT} pin) is disabled. The VSEL bits must be set again by the master after the overtemperature condition is removed (OTF=0).
			0	In the case of thermal protection activation (OTF=1) the LNB output (V _{OUT} pin) is automatically enabled as soon as the overtemperature condition is removed (OTF=0) with the previous VSEL bits setting.
Bit 7 (MSb)	COMP	-	0	Reserved. Keep to "0"

7.4 Status registers

The STATUS 1, 2 registers can be addressed only in read mode and provide the diagnostic functions described in the following tables.

Table 10. STATUS 1 (read register. Register address = 0X0)

Bit	Name	CH	Value	Description
Bit 0 (LSb)	OLF-A	A	1	V _{OUT} pin overload protection has been triggered (I _{OUT} > I _{MAX}). Refer to Table 8 for the overload operation and PCL settings.
			0	No overload protection has been triggered to the V _{OUT} pin (I _{OUT} < I _{MAX}).
Bit 1	OLF-B	B	1	V _{OUT} pin overload protection has been triggered (I _{OUT} > I _{MAX}). Refer to Table 8 for the overload operation and PCL settings.
			0	No overload protection has been triggered to V _{OUT} pin (I _{OUT} < I _{MAX}).
Bit 2	N/A	-	-	Reserved
Bit 3	N/A	-	-	Reserved
Bit 4	N/A	-	-	Reserved
Bit 5	N/A	-	-	Reserved
Bit 6	OTF	A/B	1	Junction overtemperature is detected, T _J > 150 °C (typ.). See also THERM bit setting in Table 9 .
			0	Junction overtemperature not detected, T _J < 135 °C (typ.). T _J is below thermal protection threshold.
Bit 7 (MSb)	PNG	A/B	1	Input voltage (V _{CC} pin) lower than LPD minimum thresholds. Refer to Table 12 .
			0	Input voltage (V _{CC} pin) higher than LPD thresholds. Refer to Table 12 .

N/A = Reserved bit.

All bits reset to “0” at power-on.

Table 11. STATUS 2 (read register. Register address = 0X1)

Bit	Name	CH	Value	Description
Bit 0 (LSb)	N/A	-	-	Reserved
Bit 1	N/A	-	-	Reserved
Bit 2	N/A	-	-	Reserved
Bit 3	N/A	-	-	Reserved
Bit 4	N/A	-	-	Reserved
Bit 5	N/A	-	-	Reserved
Bit 6	N/A	-	-	Reserved
Bit 7 (MSb)	N/A	-	-	Reserved

N/A = Reserved bit.

All bits reset to “0” at power-on.

8 Electrical characteristics

Refer to [Section 5](#), T_J from 0 to 85 °C, all DATA 1..4 register bits set to 0 unless VSEL1 = 1, RSEL = 11 kΩ, DSQIN = LOW, V_{IN} = 12 V, I_{OUT} = 50 mA, unless otherwise stated. Typical values are referred to T_J = 25 °C. V_{OUT} = V_{OUT} pin voltage. See software description section for I²C access to the system register ([Section 6](#) and [Section 7](#)).

Table 12. Electrical characteristics of section A/B

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{IN}	Supply voltage ⁽¹⁾		8	12	16	V
I_{IN}	Supply current	Both sections A and B enabled, I_{OUT} = 0 mA		12		mA
		22 kHz tone enabled (TEN-A/B = 1, DSQIN-A/B = High), I_{OUT} = 0 mA		19		
		Both sections A and B set in standby: VSEL1=VSEL2=VSEL3=VSEL4=0		2		
V_{OUT}	Output voltage total accuracy	Valid at any V_{OUT} selected level	-3.5		+3.5	%
V_{OUT}	Line regulation	V_{IN} = 8 to 16 V			40	mV
V_{OUT}	Load regulation	I_{OUT} from 50 to 500 mA		75	100	
I_{MAX}	Output current limiting thresholds	RSEL = 15 kΩ	500		750	mA
		RSEL = 20 kΩ	350		550	
I_{SC}	Output short-circuit current	RSEL = 15 kΩ		350		mA
SS	Soft-start time	V_{OUT} from 0 to 13 V		4		ms
SS	Soft-start time	V_{OUT} from 0 to 18 V		6		ms
T13-18	Soft transition rise time	V_{OUT} from 13 to 18 V		1.5		ms
T18-13	Soft transition fall time	V_{OUT} from 18 to 13 V		1.5		ms
T_{OFF}	Dynamic overload protection OFF time	PCL = 0, output shorted		900		ms
T_{ON}	Dynamic overload protection ON time	PCL = 0, output shorted		$T_{OFF}/10$		
A_{TONE}	Tone amplitude	DSQIN=High, EXTM=0, TEN=1 I_{OUT} from 0 to 500 mA C_{BUS} from 0 to 750 nF	0.55	0.675	0.8	V_{PP}
F_{TONE}	Tone frequency	DSQIN=High, EXTM=0, TEN=1	20	22	24	kHz
D_{TONE}	Tone duty cycle		43	50	57	%
tr, tf	Tone rise or fall time ⁽²⁾		5	8	15	μs
Eff _{DC/DC}	DC-DC converter efficiency	I_{OUT} = 500 mA		93		%
F_{SW}	DC-DC converter switching frequency			440		kHz
UVLO	Undervoltage lockout thresholds	UVLO threshold rising		4.8		V
		UVLO threshold falling		4.7		

Table 12. Electrical characteristics of section A/B (continued)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{LP}	Low power diagnostic (LPD) thresholds	V_{LP} threshold rising		7.2		V
		V_{LP} threshold falling		6.7		
V_{IL}	DSQIN, pin logic low				0.8	V
V_{IH}	DSQIN, pin logic high		2			V
I_{IH}	DSQIN, pin input current	$V_{IH} = 5\text{ V}$		15		μA
I_{OBK}	Output backward current	All $V_{SELx} = 0$, $V_{OBK} = 30\text{ V}$		-3	-6	mA
I_{SINK}	Output low-side sink current	V_{OUT} forced at $V_{OUT_nom} + 0.1\text{ V}$		70		mA
$I_{SINK_TIME-OUT}$	Low-side sink current time-out	V_{OUT} forced at $V_{OUT_nom} + 0.1\text{ V}$		10		ms
I_{REV}	Max. reverse current	V_{OUT} forced at $V_{OUT_nom} + 0.1\text{ V}$, after $I_{SINK_TIME-OUT}$ is elapsed.		2		mA
T_{SHDN}	Thermal shutdown threshold			150		$^{\circ}\text{C}$
ΔT_{SHDN}	Thermal shutdown hysteresis			15		$^{\circ}\text{C}$

1. In applications where $(V_{CC} - V_{OUT}) > 1.3\text{ V}$, the increased power dissipation inside the integrated LDO must be taken into account in the application thermal management design.
2. Guaranteed by design.

8.1 Output voltage selection

Each LNBH26L channel is provided with 8 output voltage levels (4 levels for 13 V range when $V_{SEL4-A/B}=0$ and 4 levels for 18 V range when $V_{SEL4-A/B}=1$) which can be selected through the register Data1. The following table shows the output voltage values corresponding to V_{SELx} bit combinations both for channel A and B. If all V_{SELx} are at "0" the device is set in standby mode and the $V_{OUT-A/B}$ are disabled.

Table 13. Output voltage selection table (Data1 register, write mode) ⁽¹⁾

VSEL4-A/B	VSEL3-A/B	VSEL2-A/B	VSEL1-A/B	V _{OUT} min.	V _{OUT} -A/B pin voltage	V _{OUT} max.	Function
0	0	0	0		0		V _{OUT} -A/B disabled. LNBH26L set in standby mode
0	0	0	1	12.545	13.000	13.455	
0	0	1	0	12.867	13.333	13.800	
0	0	1	1	13.188	13.667	14.145	
0	1	0	0	13.51	14.000	14.490	
1	0	0	0	17.515	18.150	18.785	
1	0	0	1	17.836	18.483	19.130	
1	0	1	0	18.158	18.817	19.475	
1	0	1	1	18.48	19.150	19.820	

1. T_J from 0 to 85 °C, V_I = 12 V.

T_J from 0 to 85 °C, V_I = 12 V.

Table 14. I²C electrical characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V _{IL}	Low level input voltage	SDA, SCL			0.8	V
V _{IH}	High level input voltage	SDA, SCL	2			V
I _{IN}	Input current	SDA, SCL, V _{IN} = 0.4 to 4.5 V	-10		10	μA
V _{OL}	Low level output voltage ⁽¹⁾	SDA (open drain), I _{OL} = 6 mA			0.6	V
F _{MAX}	Maximum clock frequency	SCL	400			kHz

1. Guaranteed by design.

T_J from 0 to 85 °C, V_I = 12 V.

Table 15. Address pin characteristics

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V _{ADDR-1}	“0001000(R/W)” Address pin voltage range	R/W bit determines the transmission mode: read (R/W=1) write (R/W=0)	0		0.8	V
V _{ADDR-2}	“0001001(R/W)” Address pin voltage range	R/W bit determines the transmission mode: read (R/W=1) write (R/W=0)	2		5	V

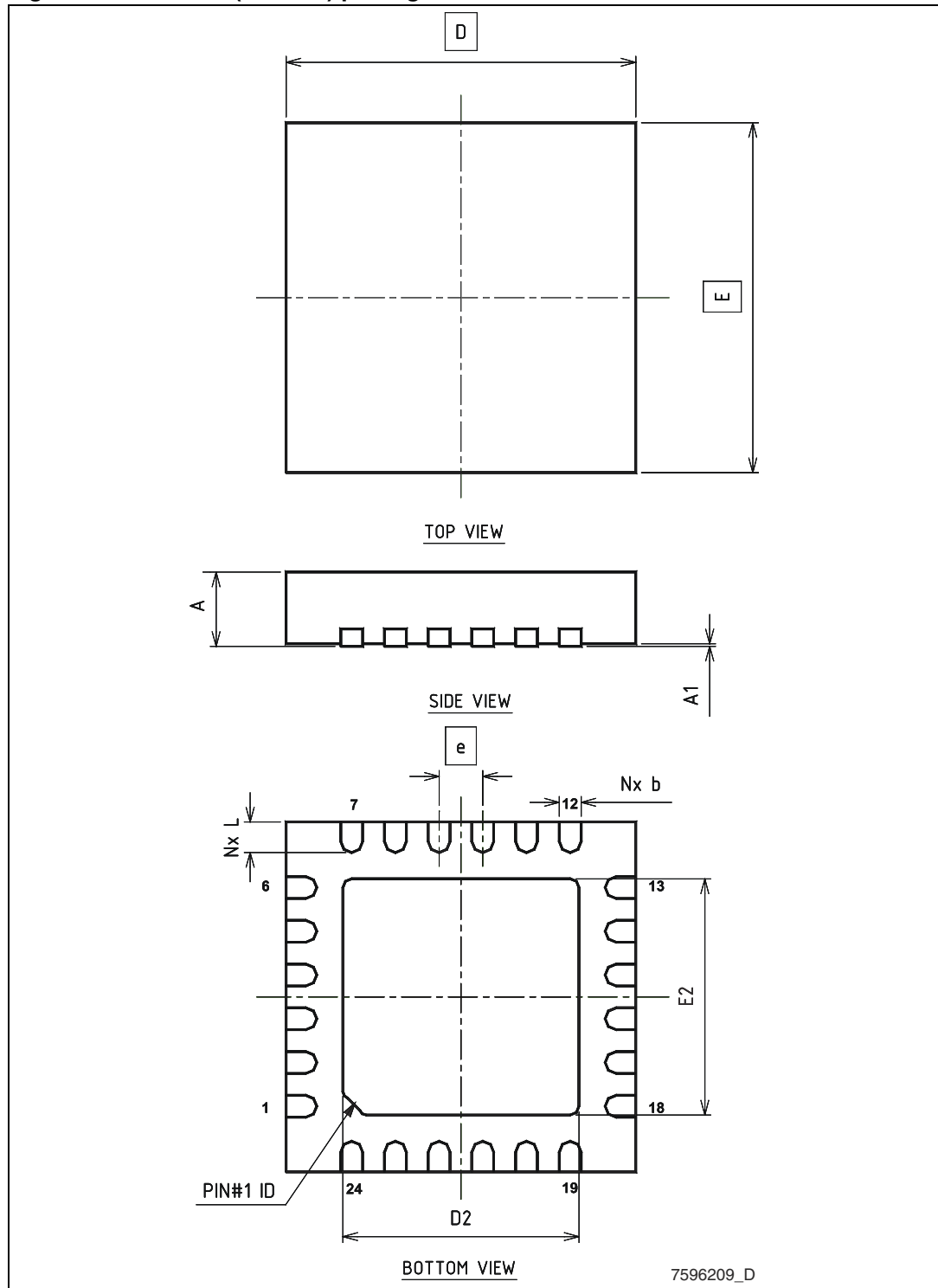
9 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Table 16. QFN24L (4x4 mm) mechanical data

Dim.	(mm)		
	Min.	Typ.	Max.
A	0.80	0.90	1.00
A1	0.00	0.02	0.05
b	0.18	0.25	0.30
D	3.90	4.00	4.10
D2	2.55	2.70	2.80
E	3.90	4.00	4.10
E2	2.55	2.70	2.80
e	0.45	0.50	0.55
L	0.25	0.35	0.45

Figure 12. QFN24L (4x4 mm) package dimensions



Tape & reel QFNxx/DFNxx (4x4) mechanical data

Dim.	mm.			inch.		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A			330			12.992
C	12.8		13.2	0.504		0.519
D	20.2			0.795		
N	99		101	3.898		3.976
T			14.4			0.567
Ao		4.35			0.171	
Bo		4.35			0.171	
Ko		1.1			0.043	
Po		4			0.157	
P		8			0.315	

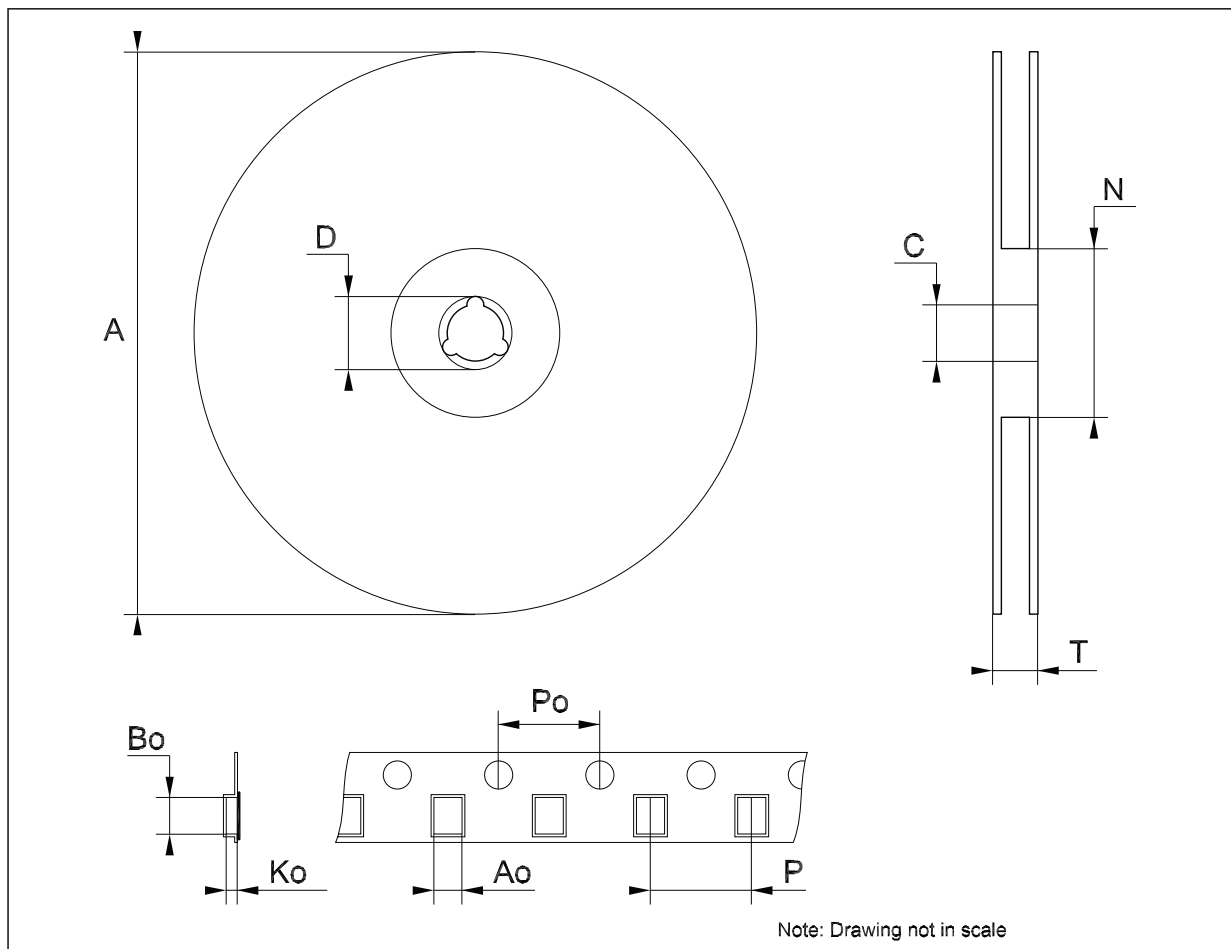
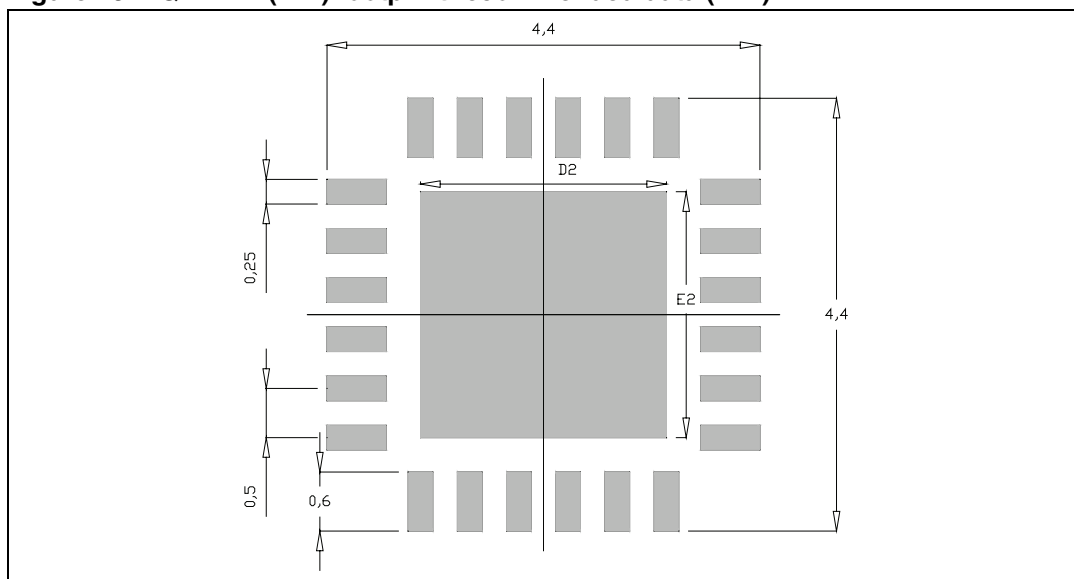


Figure 13. QFN24L (4x4) footprint recommended data (mm)



10 Revision history

Table 17. Document revision history

Date	Revision	Changes
01-Mar-2012	1	Initial release.

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